TOSHIBA Field Effect Transistor Silicon N/P Channel MOS Type

SSM6L05FU

Power Management Switch High Speed Switching Applications

- Small package
- Low on resistance Q1: $R_{on} = 0.8 \Omega (max) (@V_{GS} = 4 V)$

Q2: $R_{on} = 3.3 \Omega (max) (@V_{GS} = -4 V)$

• Low gate threshold voltage

Q1 Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-Source voltage		V _{DS}	20	V	
Gate-Source voltage		V _{GSS}	±12	V	
Drain current	DC	Ι _D	400	mA	
	Pulse	I _{DP}	800	ma	

Q2 Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-Source voltage		V _{DS}	-20	V
Gate-Source voltage		V _{GSS}	±12	V
Drain current	DC	۱ _D	-200	mA
	Pulse	I _{DP}	-400	ША

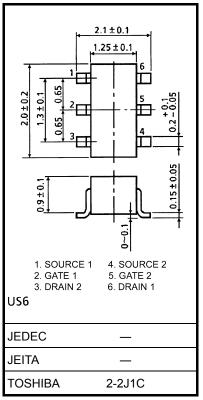
Absolute Maximum Ratings (Q1, Q2 common) (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Drain power dissipation (Ta = 25° C)	P _D (Note 1)	300	mW
Channel temperature	T _{ch}	150	°C
Storage temperature range	T _{stg}	-55~150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Total rating, mounted on FR4 board (25.4 mm \times 25.4 mm \times 1.6 t, Cu Pad: 0.32 mm $^2 \times$ 6)



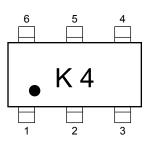
Weight: 6.8 mg (typ.)

Unit: mm

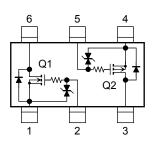
Handling Precaution

When handling individual devices (which are not yet mounting on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.

Marking



Equivalent Circuit (top view)



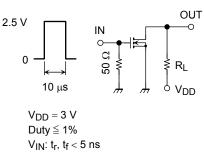
Q1 Electrical Characteristics (Ta = 25°C)

Characte	eristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS}=\pm 12~V,~V_{DS}=0$	_	_	±1	μA
Drain-Source breakdown voltage		V (BR) DSS	$I_D = 1 \text{ mA}, V_{GS} = 0$	20	_		V
Drain cut-off current		IDSS	$V_{DS} = 20 V, V_{GS} = 0$	_	_	1	μA
Gate threshold voltage		V _{th}	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 0.1 \text{ mA}$	0.6	_	1.1	V
Forward transfer admittance		Y _{fs}	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 200 \text{ mA}$ (Note2)	350	_		mS
Drain-Source ON resistance		R _{DS (ON)}	$I_D = 200 \text{ mA}, V_{GS} = 4 \text{ V}$ (Note2)		0.6	0.8	Ω
			$I_D = 200 \text{ mA}, V_{GS} = 2.5 \text{ V}$ (Note2)	_	0.85	1.2	
Input capacitance		C _{iss}		_	22		pF
Reverse transfer capacitance		C _{rss}	$V_{DS} = 3 V$, $V_{GS} = 0$, f = 1 MHz	_	9		pF
Output capacitance		C _{oss}	1		21		pF
Switching time	Turn-on time	t _{on}	$V_{DD} = 3 V, I_D = 100 mA,$		60		ns
	Turn-off time	t _{off}	V _{GS} = 0~2.5 V	_	70		

Note2: Pulse test

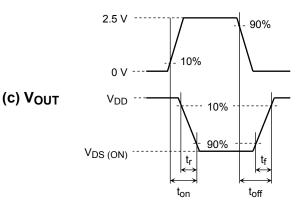
Switching Time Test Circuit (Q1: Nch MOS FET)

(a) Test circuit



 $\begin{array}{l} \text{Duty} \leq 1\% \\ \text{V}_{\text{IN}} : t_{\text{r}}, \, t_{\text{f}} < 5 \, \text{ns} \\ (Z_{\text{out}} = 50 \, \Omega) \\ \text{Common Source} \\ \text{Ta} = 25^{\circ}\text{C} \end{array}$

(b) V_{IN}



Precaution

 V_{th} can be expressed as voltage between gate and source when low operating current value is I_D = 100 μA for this product. For normal switching operation, V_{GS} (_on) requires higher voltage than V_{th} and V_{GS} (_off) requires lower voltage than V_{th} . (Relationship can be established as follows: V_{GS} (_off) $< V_{th} < V_{GS}$ (_on))

Please take this into consideration for using the device.

Q2 Electrical Characteristics (Ta = 25°C)

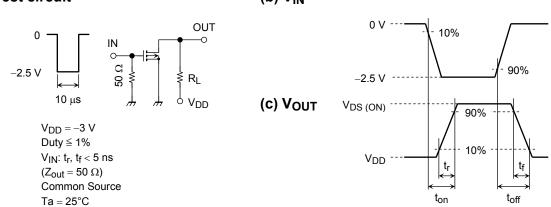
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS}=\pm 12~V,~V_{DS}=0$	_	_	±1	μA
Drain-Source breakdo	wn voltage	V (BR) DSS	$I_D = -1 \text{ mA}, V_{GS} = 0$	-20			V
Drain cut-off current		I _{DSS}	$V_{DS} = -20 V, V_{GS} = 0$			-1	μA
Gate threshold voltage		V _{th}	$V_{DS} = -3 \text{ V}, \text{ I}_{D} = -0.1 \text{ mA}$	-0.6	—	-1.1	V
Forward transfer admittance		Y _{fs}	$V_{DS} = -3 \text{ V}, \text{ I}_{D} = -50 \text{ mA} (\text{Note2})$	100			mS
Drain-Source ON resistance		R _{DS (ON)}	$I_D = -100 \text{ mA}, V_{GS} = -4 \text{ V}$ (Note2)	_	2.1	3.3	Ω
			$I_D = -50$ mA, $V_{GS} = -2.5$ V (Note2)	_	3.2	4.0	
Input capacitance		C _{iss}		_	27		pF
Reverse transfer capacitance		C _{rss}	$V_{DS} = -3 V$, $V_{GS} = 0$, f = 1 MHz	_	7		pF
Output capacitance		C _{oss}			21		pF
Switching time	Turn-on time	t _{on}	$V_{DD} = -3 \text{ V}, \text{ I}_D = -50 \text{ mA},$		70		ns
	Turn-off time	t _{off}	V _{GS} = 0~-2.5 V	_	70		

Note2: Pulse test

Switching Time Test Circuit (Q2: Pch MOS FET)





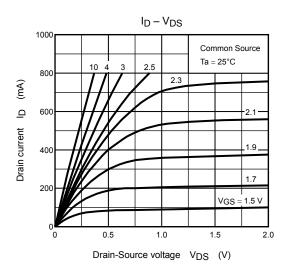


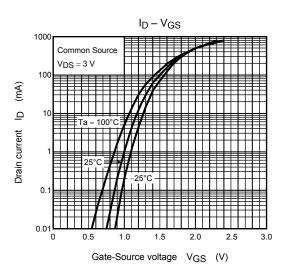
Precaution

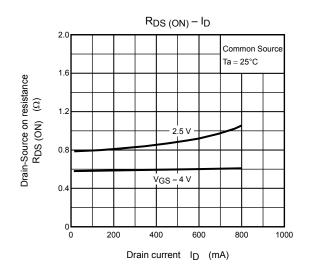
 V_{th} can be expressed as voltage between gate and source when low operating current value is I_D = $-100~\mu A$ for this product. For normal switching operation, V_{GS} (on) requires higher voltage than V_{th} and V_{GS} (off) requires lower voltage than V_{th} . (Relationship can be established as follows: V_{GS} (off) $< V_{th} < V_{GS}$ (on))

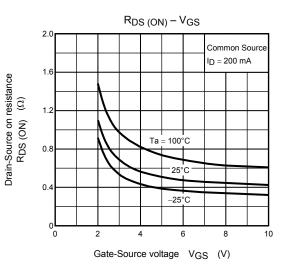
Please take this into consideration for using the device.

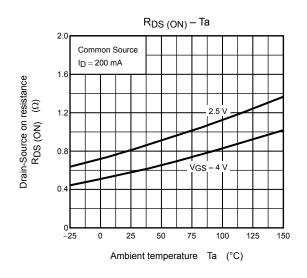
Q1 (Nch MOS FET)

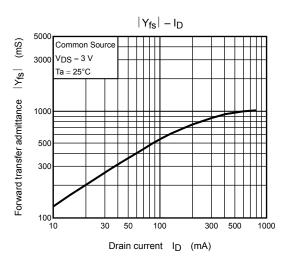




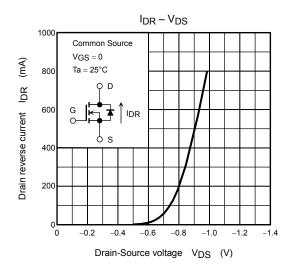


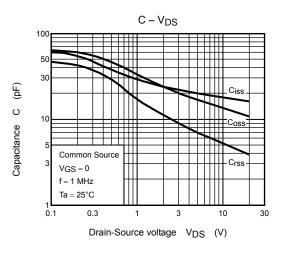


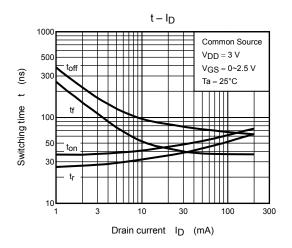




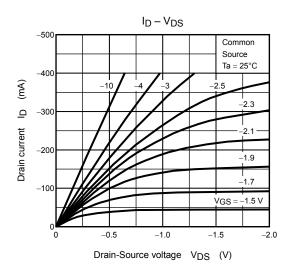
Q1 (Nch MOS FET)

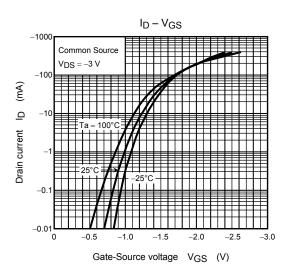


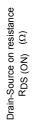


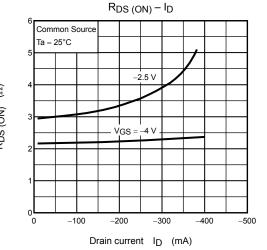


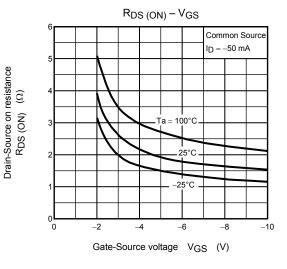
Q2 (Pch MOS FET)

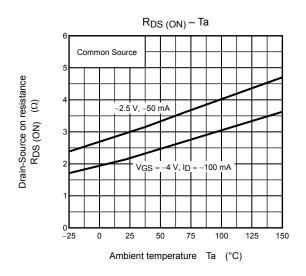


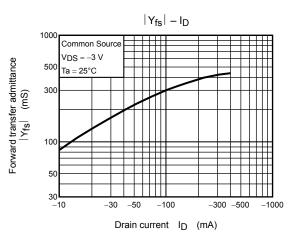




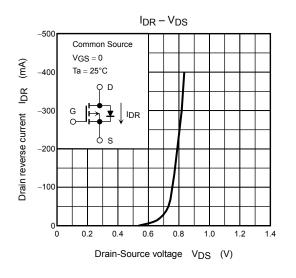


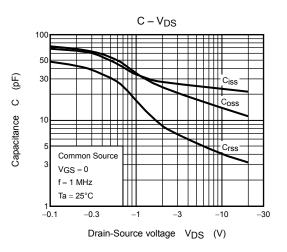


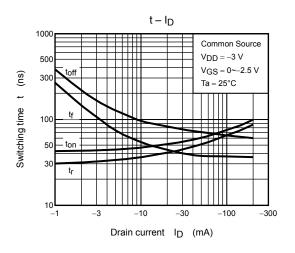


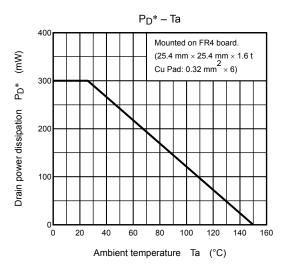


Q2 (Pch MOS FET)









*: Total rating

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20070701-EN GENERAL

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